


<b>Search Notes</b>  	<b>Application/Control No.</b>  10708536	<b>Applicant(s)/Patent Under Reexamination</b>  ZHOU ET AL.
	<b>Examiner</b>  ERIN D CHIEM	<b>Art Unit</b>  2883

SEARCHED			
Class	Subclass	Date	Examiner
359	653	12/17/08	edc

SEARCH NOTES		
Search Notes	Date	Examiner
text and class/subclass narrowed by application date (***Wang***)	12/17/08	edc

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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